Spring-loaded test probe GKS-075 225 130 A 1000

Item GKS-075-0057

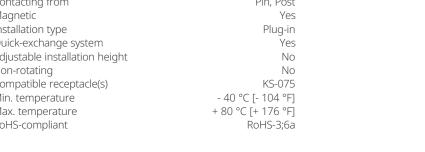




- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- Various spring forces available as well as versions with stainless steel springs suitable for high temperatures

General data

Product aroup ICT / FCT (in-circuit test and function test Sub-product group Standard stroke test probe Series GKS-075 Grid 1.91 mm [75 mil] Contacting from Pin, Post Magnetic Installation type Quick-exchange system Adjustable installation height Non-rotating Compatible receptacle(s) Min. temperature Max. temperature RoHS-compliant



Electrical data

Current load capacity / rated current 3 A Typical resistance (Ri) <20 mOhm

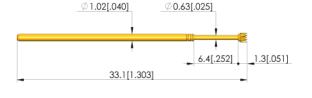
Mechanical data

Total length 33.1 mm [1.30 in] Barrel diameter 1.02 mm [.040 in] Maximum stroke 6.35 mm [.25 in] Spring pre-load 0.4 N [1.43 ozf] Collar height 00 Spring force at working stroke 1 N [3.59 ozf] Recommended working stroke 4.3 mm [.169 in]



Tip style 25 6-point crown with middle point, self-cleaning Tip diameter 1.3 mm [.051 in] Tip style surface A gold Tip style material 2 steel



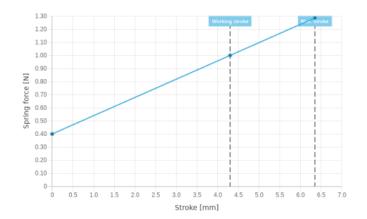




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Learn more about ICT/FCT Test probes

